

## Power MOSFET

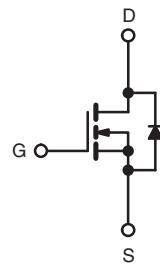
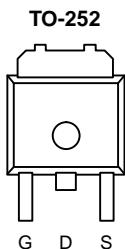
PRODUCT SUMMARY		
V <sub>DS</sub> (V)	400	
R <sub>D(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	3.5
Q <sub>g</sub> (Max.) (nC)		17
Q <sub>gs</sub> (nC)		3.4
Q <sub>gd</sub> (nC)		8.5
Configuration		Single

### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



**RoHS\***  
COMPLIANT



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>GS</sub> at 10 V	V <sub>DS</sub>	400	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	
Continuous Drain Current		I <sub>D</sub>	2.0	A
	T <sub>C</sub> = 25 °C		1.2	
Pulsed Drain Current <sup>a</sup>	V <sub>GS</sub> at 10 V	I <sub>DM</sub>	6.0	W/°C
Linear Derating Factor			0.29	
Single Pulse Avalanche Energy <sup>b</sup>	T <sub>C</sub> = 100 °C	E <sub>AS</sub>	120	mJ
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	2.0	
Repetitive Avalanche Energy <sup>a</sup>	T <sub>C</sub> = 25 °C	E <sub>AR</sub>	3.6	mJ
Maximum Power Dissipation		P <sub>D</sub>	36	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	4.0	V/ns
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	°C
Mounting Torque			10	lbf · in
			1.1	N · m

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- V<sub>DD</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 52 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 2.0 A (see fig. 12).
- I<sub>SD</sub> ≤ 2.0 A, dI/dt ≤ 40 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5	

**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		400	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.47	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V		-	-	25	μA
		V <sub>DS</sub> = 320 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.2 A <sup>b</sup>	-	3.5	-	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.2 A <sup>b</sup>		1.0	-	-	S
<b>Dynamic</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	170	-	pF
Output Capacitance	C <sub>oss</sub>			-	34	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	6.3	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.0 A, V <sub>DS</sub> = 320 V see fig. 6 and 13 <sup>b</sup>	-	-	17	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	3.4	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	8.5	
Turn-On Delay Time	t <sub>d(on)</sub>			-	8.0	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 200 V, I <sub>D</sub> = 2.0 A, R <sub>g</sub> = 24 Ω, R <sub>D</sub> = 95 Ω see fig. 10 <sup>b</sup>		-	9.9	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		-	21	-		
Fall Time	t <sub>f</sub>		-	11	-		
Internal Drain Inductance	L <sub>D</sub>		-	4.5	-		
Internal Source Inductance	L <sub>S</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	7.5	-	nH
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.0	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	6.0	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 2.0 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 2.0 A, dI/dt = 100 A/μs <sup>b</sup>		-	240	540	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.85	1.6	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.

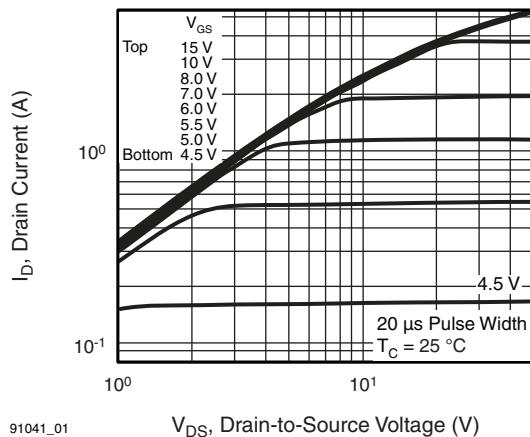
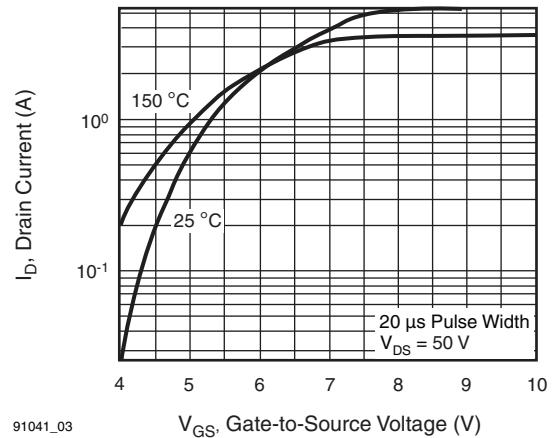
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)
Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

Fig. 3 - Typical Transfer Characteristics

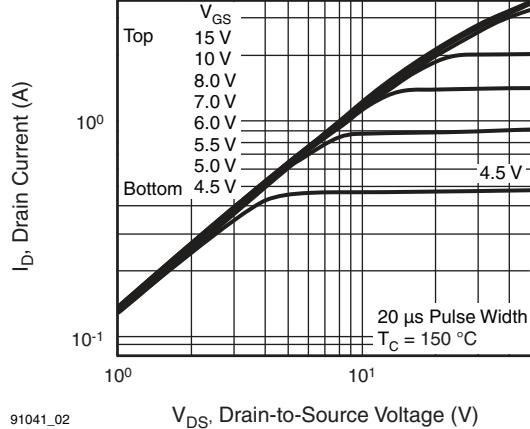
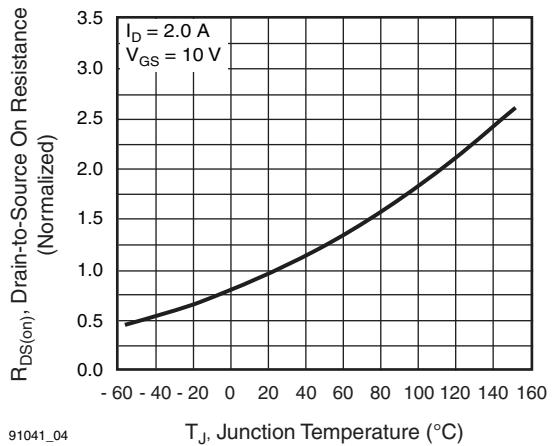
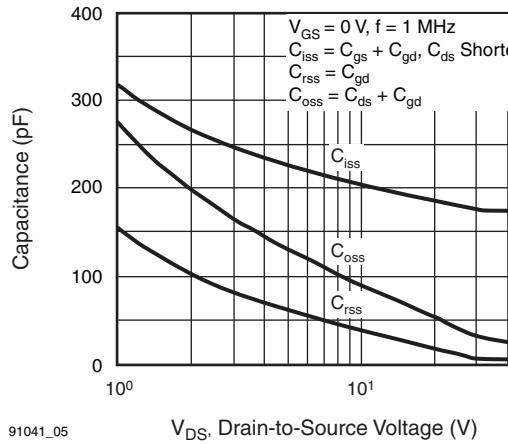
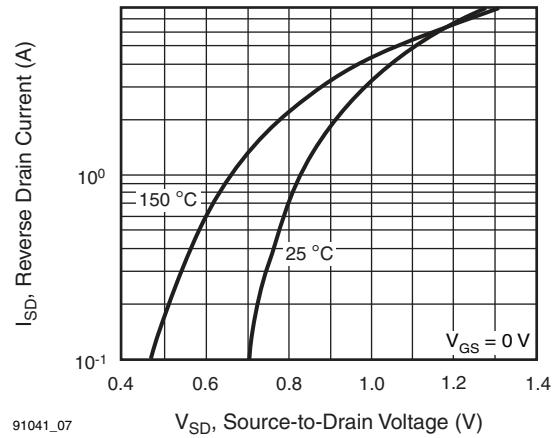
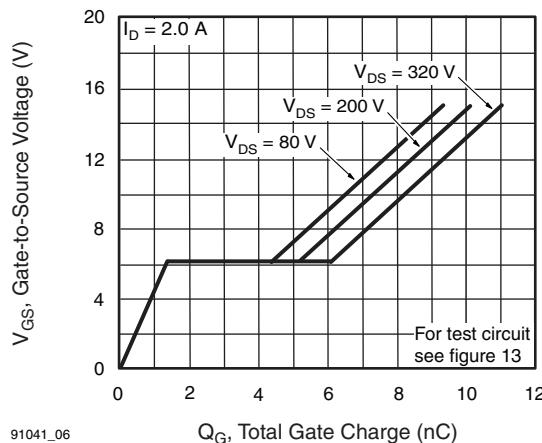
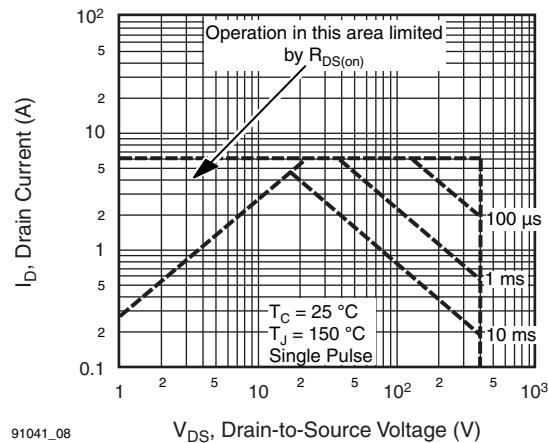
Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

Fig. 4 - Normalized On-Resistance vs. Temperature

**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage****Fig. 7 - Typical Source-Drain Diode Forward Voltage****Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage****Fig. 8 - Maximum Safe Operating Area**

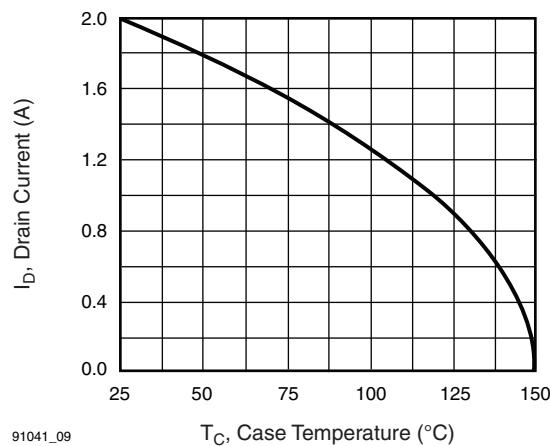


Fig. 9 - Maximum Drain Current vs. Case Temperature

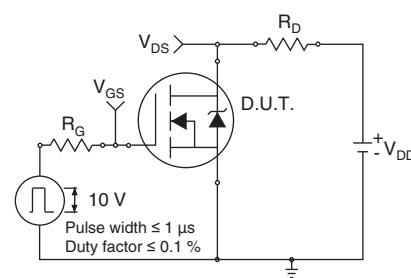


Fig. 10a - Switching Time Test Circuit

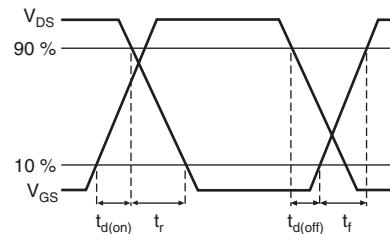


Fig. 10b - Switching Time Waveforms

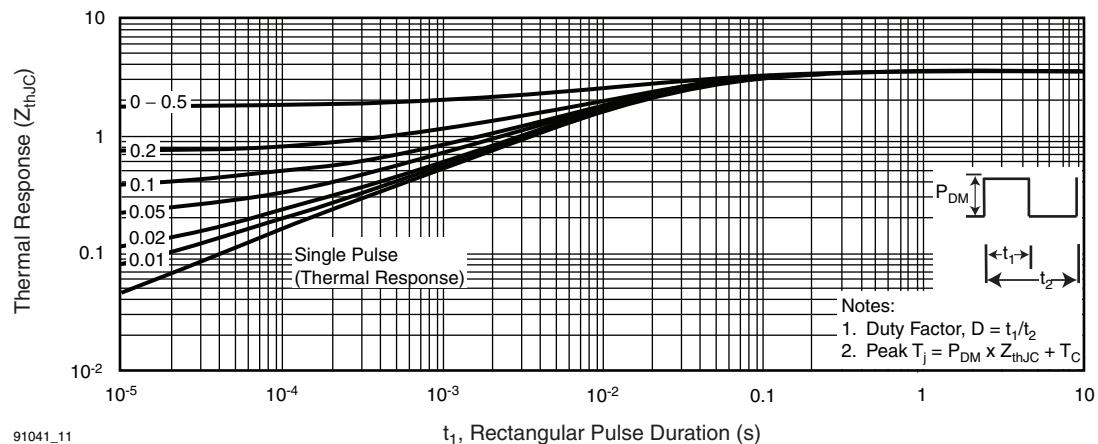


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

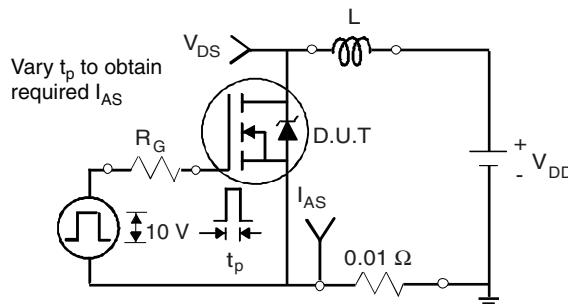


Fig. 12a - Unclamped Inductive Test Circuit

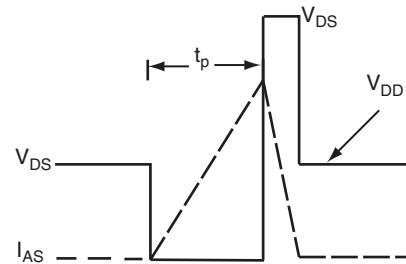


Fig. 12b - Unclamped Inductive Waveforms

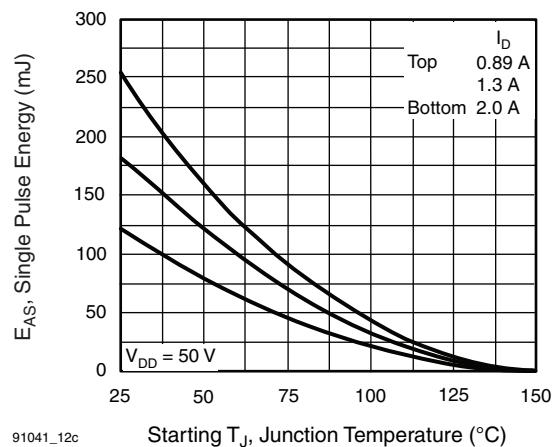


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

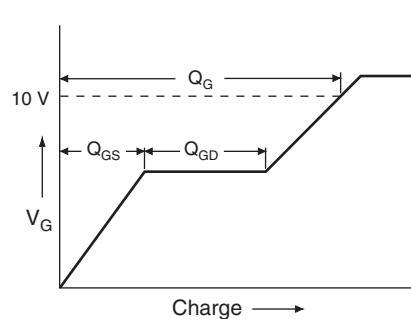


Fig. 13a - Basic Gate Charge Waveform

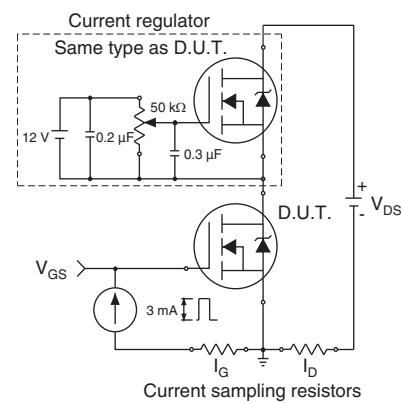
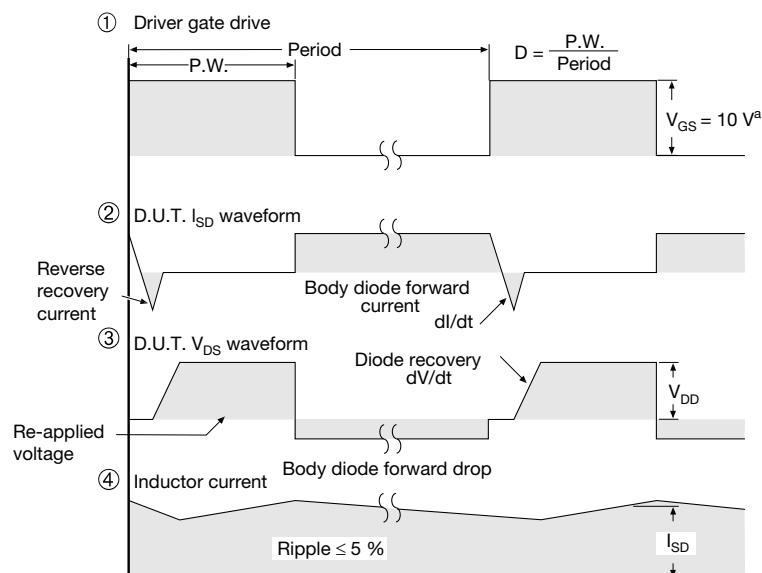
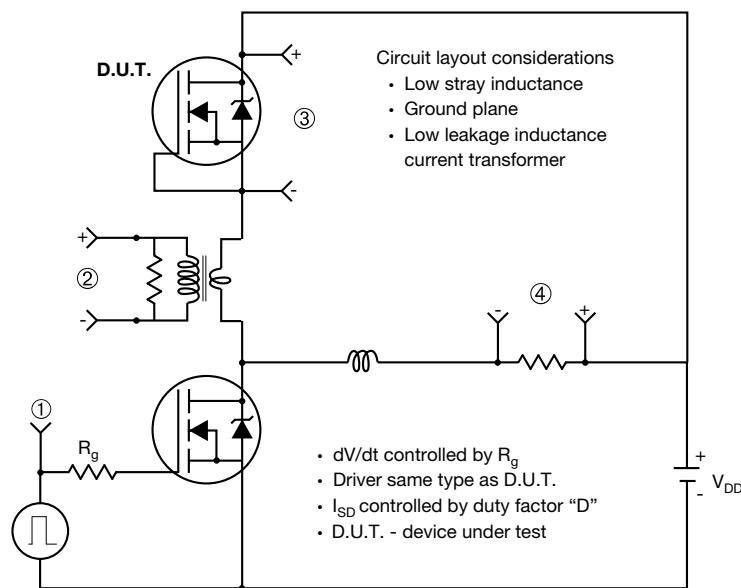


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery $dV/dt$ Test Circuit

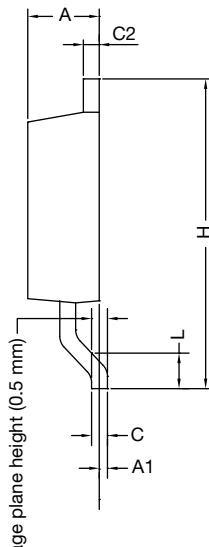
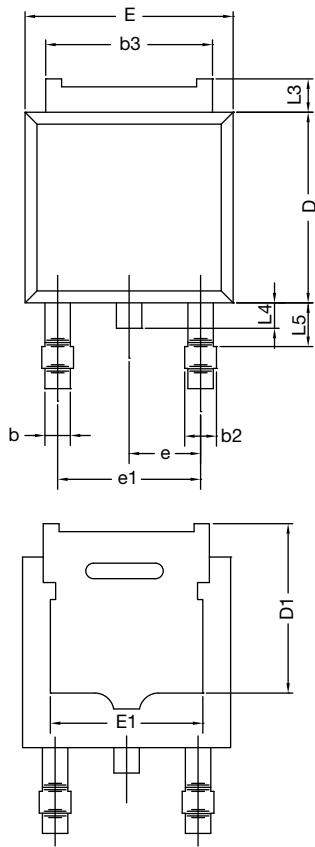


**Note**

a.  $V_{GS} = 5 \text{ V}$  for logic level devices

**Fig. 14 - For N-Channel**

## TO-252AA CASE OUTLINE



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
C	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	-	0.205	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
H	9.40	10.41	0.370	0.410
e	2.28 BSC		0.090 BSC	
e1	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.14	1.52	0.045	0.060

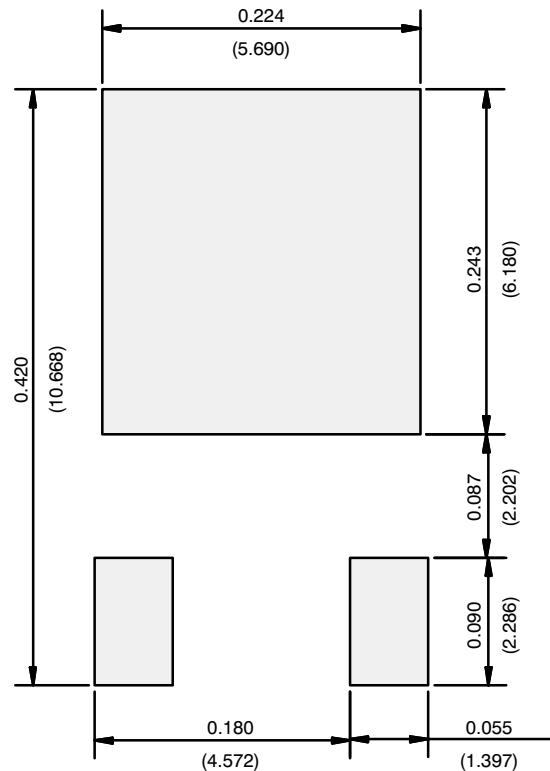
ECN: X12-0247-Rev. M, 24-Dec-12

DWG: 5347

### Note

- Dimension L3 is for reference only.

## RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads  
Dimensions in Inches/(mm)

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